

1 VOLT HIGH SPEED CMOS TIMER

GENERAL DESCRIPTION

The ALD555-1 timer is a high performance 1 volt operation monolithic timing circuit built with advanced silicon gate CMOS technology. It offers the benefits of high input impedance, thereby allowing smaller timing capacitors and longer timing cycle; high speed, with typical cycle time of 500ns; low power dissipation for battery operated environment; reduced supply current spikes, allowing smaller and lower cost decoupling capacitors.

It is capable of producing accurate time delays and oscillations in both monostable and astable operation. It operates in the one-shot (monostable) mode or 50% duty cycle free running oscillation mode with a single resistor and one capacitor. The inputs and outputs are fully compatible with CMOS, NMOS or TTL logic.

There are three matched internal resistors (approximately 200KΩ each) that set the threshold and trigger levels at two-thirds and one-third respectively of V_{DD} . These levels can be adjusted by using the control terminal (pin 5). When the trigger input is below the trigger level, the output is in the high state and sourcing 2mA. When threshold input is above the threshold level at the same time the trigger input is above the trigger level, the internal flip-flop is reset, the output goes to the low state and sinks up to 10mA. The reset input overrides all other inputs and when it is active (reset voltage less than 1V), the output is in the low state.

FEATURES

- Guaranteed low operating supply voltage of 1 to 12V
- Functional equivalent to NE555 with greatly expanded high and low frequency ranges
- Compatible with ALD 555 Timer
- High speed, low power, monolithic CMOS technology
- Low supply current 75μA typical at 1V operation
- Extremely low trigger, threshold and reset currents - 1pA typical
- High speed operation - 2 MHz oscillation at 5V
- Operates in both monostable and astable modes
- Fixed 50% duty cycle or adjustable duty cycle
- CMOS, NMOS and TTL compatible input/output
- High discharge sinking current 80mA at 5V and 10mA at 1V
- Low supply current spikes

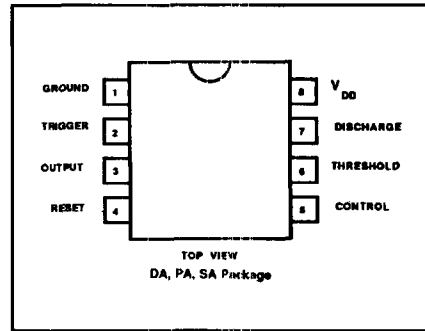
ORDERING INFORMATION

Operating Temperature		
-55°C to +125°C	0° C to +70° C	0° C to +70° C
8 Pin Ceramic Package	8 Pin Plastic Mini DipPackage	8 Pin SOIC Package
ALD 555-1 DA	ALD 555-1 PA	ALD 555-1 SA

Advanced Linear Devices, Inc. cannot assume liability for use of circuits described and reserves the right to change any circuitry and specifications without notice at any time. No circuit patent licenses are implied. Liability of circuits if manufacture is limited as covered under its standard product warranty policy. No life support applications are authorized. ©1986

Tel: (408) 720-8737 Fax: (408) 720-8297

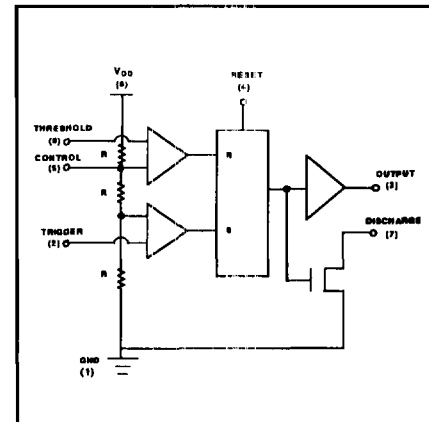
PIN CONFIGURATION



APPLICATIONS

- Ideal for 1.5V battery operated timer
- Micropower timing generator with quiescent power of 75μW typical
- Power saving emergency flasher controls
- Automatic shut-off of portable instruments
- High speed one-shot (monostable) pulse generation
- Precision timing
- Sequential timing
- Long delay timer
- Pulse width and pulse position modulation
- Missing pulse detector
- Frequency divider

BLOCK DIAGRAM



ABSOLUTE MAXIMUM RATINGS

Supply voltage, V_{DD}	13.2V
Input voltage range	-0.3V to V_{DD}
Power dissipation	600mW
Operating temperature range	555-1 PA, 555-1 SA 0° C to +70° C
	555-1 DA -55° C to +125° C
Storage temperature range	-65° C to +150° C
Lead temperature, 10 seconds	300° C

DC AND OPERATING ELECTRICAL CHARACTERISTICS

$V_{DD} = +1V$ $T_A = +25^\circ C$ unless otherwise specified

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions
Supply Current	I_{DD}		75	150	μA	Outputs Unloaded
Output Voltage (low)	V_{OL}		0.02	0.4	V	$I_{SINK} = 0.2 \text{ mA}$
Output Voltage (high)	V_{OH}	0.5	0.8		V	$I_{SOURCE} = 0.1 \text{ mA}$
Rise Time	t_r		300		nS	$R_{LOAD} = 10M\Omega$
Fall Time	t_f		100		nS	$C_{LOAD} = 10pF$
Discharge Output Voltage Drop	V_{DISC}		0.03	0.4	V	$I_{DISCHARGE} = 1 \text{ mA}$
Maximum frequency in astable mode	f_{max}		0.3		MHz	

DC AND OPERATING ELECTRICAL CHARACTERISTICS

$T_A = 25^\circ C$ $V_{DD} = +5V$ unless otherwise specified

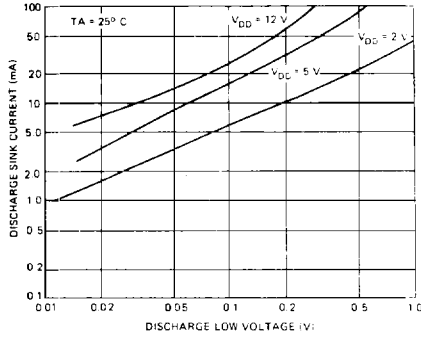
Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions
Supply voltage	V_{DD}	1		12	V	
Supply current	I_{DD}		100	180	μA	Outputs Unloaded
Timing error / Astable mode						$C = 0.1\mu F$ $R_A = 1k\Omega$ $R_B = 1k\Omega$
Initial Accuracy	t_{err}		1.0	2.2	%	
Drift with Temperature ¹	$\Delta t/\Delta T$		10.0		ppm/°C	
Drift with Supply Voltage ¹	$\Delta t/\Delta V_{DD}$		0.1		%/V	
Threshold Voltage	V_{th}	3.273	3.333	3.393	V	
Trigger Voltage	V_{TRIG}	1.607	1.667	1.737	V	
Trigger Current ²	I_{TRIG}		.001	0.2	nA	
Reset Voltage	V_{RST}	0.4	0.7	1.0	V	
Reset Current ²	I_{RST}		.001	0.2	nA	
Threshold Current ²	I_{th}		.001	0.2	nA	
Control Voltage Level	V_{CONT}	3.273	3.333	3.393	V	
Output Voltage (Low)	V_{OL}		0.2	0.4	V	$I_{sink} = 10mA$
Output Voltage (High)	V_{OH}			4.2	V	$I_{source} = -2mA$
Rise Time of Output ¹	t_r		15	30	ns	$R_L = 10M\Omega$
Fall Time of Output ¹	t_f		10	20	ns	$C_L = 10pF$
Discharge Transistor Leakage Current	I_{DL}		.01		nA	
Discharge Voltage Drop	V_{DISC}		0.5	1.0	V	¹ Discharge = 80mA
			0.2	0.4	V	¹ Discharge = 30mA
Maximum Frequency ¹ Astable Mode	f_{max}	1.4	2		MHz	$R_A = 470\Omega$ $R_B = 200\Omega$ $C_T = 200pF$

Notes: ¹ Sample tested parameters.

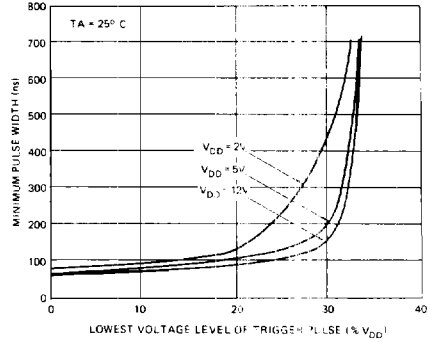
² Consists of junction leakage currents with strong temperature dependence.

TYPICAL PERFORMANCE CHARACTERISTICS

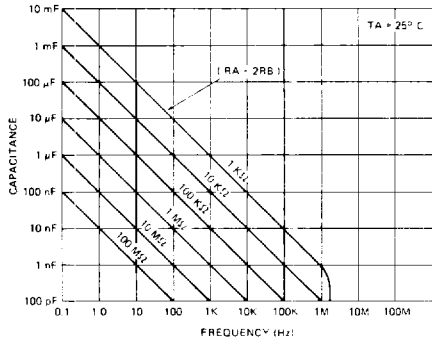
DISCHARGE OUTPUT SINK CURRENT AS A FUNCTION OF DISCHARGE LOW VOLTAGE



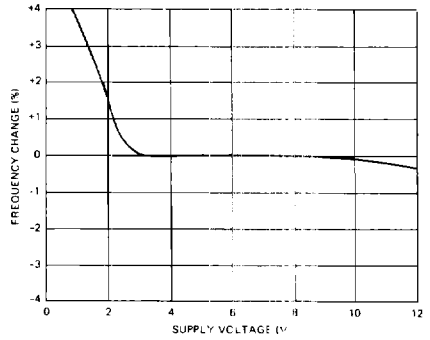
MINIMUM PULSE WIDTH REQUIRED FOR TRIGGERING



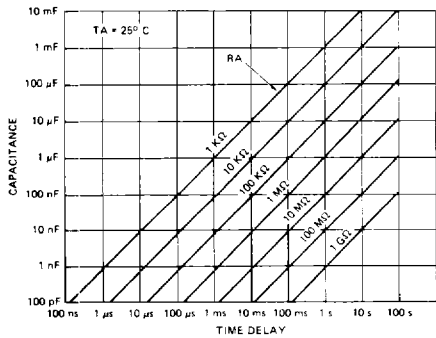
FREE RUNNING FREQUENCY AS A FUNCTION OF R_A , R_B AND C



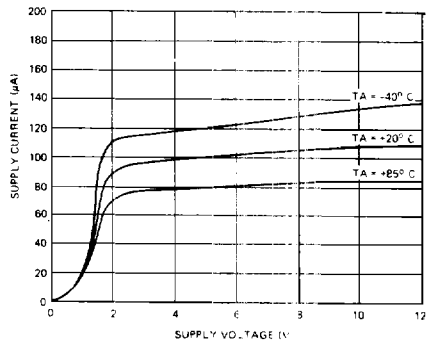
FREQUENCY CHANGE IN THE ASTABLE MODE AS A FUNCTION OF SUPPLY VOLTAGE



TIME DELAY IN THE MONOSTABLE MODE AS A FUNCTION OF R_A AND C

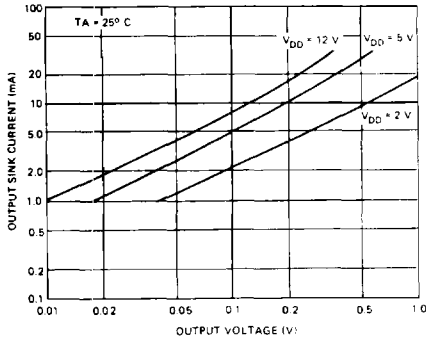


SUPPLY CURRENT AS A FUNCTION OF SUPPLY VOLTAGE

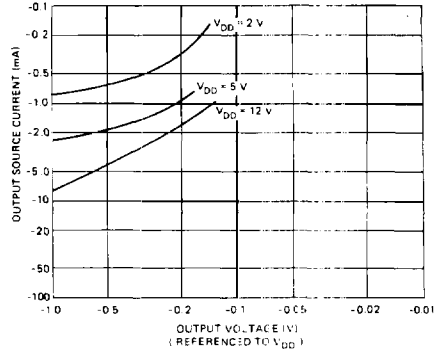


TYPICAL PERFORMANCE CHARACTERISTICS

OUTPUT SINK CURRENT AS A FUNCTION OF OUTPUT VOLTAGE

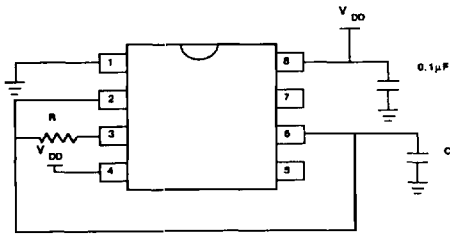


OUTPUT SOURCE CURRENT AS A FUNCTION OF OUTPUT VOLTAGE



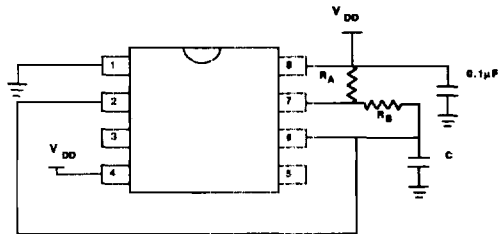
TYPICAL APPLICATIONS

ASTABLE MODE OPERATION 50% DUTY CYCLE



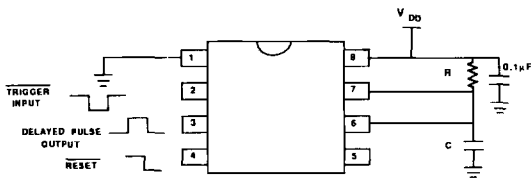
Frequency $f \approx 1/(1.4 RC)$

ASTABLE MODE OPERATION (FREE RUNNING OSCILLATOR)



Frequency $f = 1.46/(R_A + 2R_B) C$
Duty Cycle $D_c = R_B/(R_A + 2R_B)$

MONOSTABLE MODE OPERATION (ONE SHOT PULSE)
Pulse Delay $t_d = 1.1 RC$



CHIP TOPOGRAPHY

